

<b>Notice of References Cited</b>	Application/Control No. 10/617,722		Applicant(s)/Patent Under Reexamination LAI ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,076,119 A	06-2000	Maemura et al.	710/15
	B	US-2003/0204652 A1	10-2003	Saito et al.	710/33
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2003263253 A	09-2003	Japan	KANEKO et al.	G06F 03/00
	O	JP 2003044186 A	02-2003	Japan	MATSUDA et al.	G06F 03/00
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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